



Heu

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

Allowed: July 1, 2005

NISHIDA et al.

Atty. Ref.: 1035-493; Confirmation No. 4522

Appl. No. 10/762,242

TC/A.U. 2815

Filed: January 23, 2004

Examiner: J. CLARK

For: SEMICONDUCTOR DEVICE

* * * * *

November 1, 2005

Mail Stop Issue Fee
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

CORRECTED PTO-1449 FOR PREVIOUSLY FILED IDS

This corrected PTO-1449 for an IDS is submitted merely to correct a typographical error present in the previous IDS filed September 26, 2005. The minor correction made herein is that the date for the foreign document 4/2005 has been changed to "11/2003" on the PTO-1449. The reference is not provided herein, since it was submitted with the previous IDS filing of September 26, 2005. It is requested that the Examiner initial and return a copy of the corrected PTO-1449 attached hereto to the undersigned.

NISHIDA et al.
Appl. No. 10/762,242
November 1, 2005

Please let me know if you should have any questions with regard to the above.

Respectfully submitted,

NIXON & VANDERHYE P.C.

By: 

Joseph A. Rhoa
Reg. No. 37,515

JAR:caj
1100 North Glebe Road, 8th Floor
Arlington, VA 22201-4714
Telephone: (703) 816-4000
Facsimile: (703) 816-4100

INFORMATION DISCLOSURE
CITATION

~~ATTY. DOCKET NO.~~

~~SERIAL NO.~~

1035-493

10/762,242

APPLICANT

NISHIDA et al.

FILING DATE

January 23, 2004

GROUP

2815

(Use several sheets if necessary)

NOV 01 2005

U.S. PATENT DOCUMENTS

[illegible]

FOREIGN PATENT DOCUMENTS

[illegible]

OTHER DOCUMENTS (including Author, Title, Date, Pertinent pages, etc.)

		Taiwanese Office Action mailed August 16, 2005 (w/English translation thereof)

*Examiner

Date Considered

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to application.

Form PTO-FB-A820 (Also PTO-1449)